

Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
1	1S&R 3	("9107091").PN.	USPAT; JPO; DERWENT	2001/08/30 15:53		
2	BRS 118	chip with (circuit adj layer)	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 16:15		
3	BRS 0	((chip with substrate) with (through adj hole) ) and (ptfc or stress)	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 16:30		
4	BRS 6045	chip and substrate and (through adj hole)	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 16:30		
5	BRS 2	(chip and substrate and (through adj hole) ) and (ptfc or stress)	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 16:31		
6	BRS 871	(chip with substrate) with (through adj hole)	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 16:33		
7	BRS 106	(chip with((insulat\$ or dielectric)near substrate)) with (through adj hole)	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 17:19		Truncation Overflow. Return string from Server is: 5 359193
8	BRS 381	(pcb or (dielectric adj substrate)) with (polytetrafluoroethylene or ptfc or stress or relax\$)	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 17:47		
9	BRS 45	((pcb or (dielectric adj substrate)) with (polytetrafluoroethylene or ptfc or stress or relax\$) ) and ((via or through) near hole)	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 17:59		
10	BRS 515	((pcb or (dielectric adj substrate)) and (polytetrafluoroethylene or ptfc or stress or relax\$) and ((through or via) adj hole)) and ((pcb or (dielectric adj substrate)) and (polytetrafluoroethylene or ptfc or stress or relax\$) and ((through or via) adj hole)) and ((stress or relax\$) with layer)	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:14		
11	BRS 49	257/409.cc1s. and wafer	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:07		
12	BRS 81	((pcb or (dielectric adj substrate)) and (polytetrafluoroethylene or ptfc or stress or relax\$) and ((through or via) adj hole) ) and (wafer same (polytetrafluoroethylene or ptfc or stress or relax\$))	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:11		
13	BRS 86	wafer near (polytetrafluoroethylene or ptfc or stress or relax\$)	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:15		
14	BRS 5486	wafer near (polytetrafluoroethylene or ptfc or stress or relax\$)	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:58		
15	BRS 409	wafer near (polytetrafluoroethylene or ptfc or stress or relax\$)	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:59		
16	BRS 5	wafer with (polytetrafluoroethylene or ptfc )	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:58		
17	BRS 0	wafer same (polytetrafluoroethylene or ptfc )	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:59		
18	BRS 0	chip with (polytetrafluoroethylene or ptfc )	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:59		
19	BRS 0	chip with (polytetrafluoroethylene or ptfc )	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:59		
20	BRS 5	chip with (polytetrafluoroethylene or ptfc )	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:59		
21	BRS 0	wafer with (polytetrafluoroethylene or ptfc )	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:59		
22	BRS 5	wafer near (polytetrafluoroethylene or ptfc )	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:59		
23	BRS 0	wafer with (polytetrafluoroethylene or ptfc )	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:59		
24	BRS 379	wafer and (polytetrafluoroethylene or ptfc )	USPAT; JPO; DERWENT; IBM TDB	2001/08/30 18:59		

	Errors
1	0
2	0
3	0
4	0
5	0
6	0
7	1
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Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
25	361	(wafer and (polytetrafluoroethylene or ptfe) and chip) not (wafer with (polytetrafluoroethylene or ptfe ))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2001/08/30 19:20		
26	109	(wafer and (polytetrafluoroethylene or ptfe) and chip) and package	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2001/08/30 19:21		

	Errors
25	0
26	0